

**Search Notes**

Application/Control No.

10/521,907

Examiner

PAUL T. CHIN

Applicant(s)/Patent under  
Reexamination

LORTHIOIR ET AL.

Art Unit

3652

**SEARCHED**

Class	Subclass	Date	Examiner
294	28, 34	5/15/2008	PTC
16	425		
220	759	5/15/2008	PTC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR